International Rectifier

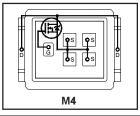
AUTOMOTIVE GRADE

AUIRF7648M2TR AUIRF7648M2TR1

Automotive DirectFET® Power MOSFET ②

- Advanced Process Technology
- Optimized for Automotive Motor Drive, DC-DC and other Heavy Load Applications
- · Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- Lead Free, RoHS Compliant and Halogen Free
- Automotive Qualified *

$V_{(BR)DSS}$	60V
R _{DS(on)} typ.	5.5m $Ω$
max.	7.0m Ω
I _{D (Silicon Limited)}	68A
Q_g	35nC





Applicable DirectFET® Outline and Substrate Outline ①

SB SC M2 M4 L4 L6 L8	
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Description

The AUIRF7648M2 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET® packaging to achieve low gate charge as well as the lowest on-state resistance in a package that has the footprint of a SO-8 and only 0.7 mm profile. The DirectFET® package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infrared or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET® package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are of value. The advanced DirectFET® packaging platform coupled with the latest silicon technology allows the AUIRF7648M2 to offer substantial system level savings and performance improvement specifically in motor drive, high frequency DC-DC and other heavy load applications on ICE, HEV and EV platforms. This MOSFET utilizes the latest processing techniques to achieve low on-resistance and low Qg per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
V _{DS}	Drain-to-Source Voltage	60	V
V_{GS}	Gate-to-Source Voltage	± 20	v
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	68	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) @	48	
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) ^③	14	А
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	179	
I _{DM}	Pulsed Drain Current ®	272	
P _D @T _C = 25°C	Power Dissipation ®	63	14/
P _D @T _A = 25°C	Power Dissipation 3	2.5	─ W
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ©	70	1
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value ®	291	mJ mJ
I _{AR}	Avalanche Current ⑤	See Fig. 18a,18b,16,17	А
E _{AR}	Repetitive Avalanche Energy ⑤		mJ
T _P	Peak Soldering Temperature	270	
T _J	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ^③		60	
$R_{\theta JA}$	Junction-to-Ambient ®	12.5		
$R_{\theta JA}$	Junction-to-Ambient [®]	20		°C/W
$R_{\theta J\text{-Can}}$	Junction-to-Can ⊕ ®		2.4	
R _{0J-PCB}	Junction-to-PCB Mounted	1.0		
	Linear Derating Factor	0	.42	W/°C

HEXFET® is a registered trademark of International Rectifier.

Static Characteristics @ $T_J = 25$ °C (unless otherwise stated)

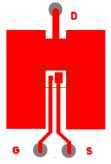
	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.07		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		5.5	7.0	mΩ	V _{GS} = 10V, I _D = 41A ⑦
V _{GS(th)}	Gate Threshold Voltage	3.0	4.0	4.9	V	V _{DS} = V _{GS} , I _D = 150μA
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Coefficient		-12		mV/°C	$V_{DS} = V_{GS}$, $I_D = 150\mu A$
gfs	Forward Transconductance	44			S	$V_{DS} = 25V, I_D = 41A$
R_G	Gate Resistance		1.4		Ω	
I _{DSS}	Drain-to-Source Leakage Current			5	μΑ	$V_{DS} = 60V, V_{GS} = 0V$
				250		$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100		$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

Dynamic Characteristics @ T_J = 25°C (unless otherwise stated)

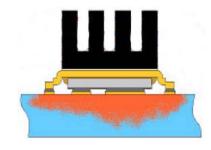
	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		35	53		$V_{DS} = 30V, V_{GS} = 10V$
Q _{gs1}	Pre-Vth Gate-to-Source Charge		7.7			I _D = 41A
Q _{gs2}	Post-Vth Gate-to-Source Charge		3.4		nC	See Fig.11
Q_{gd}	Gate-to-Drain ("Miller") Charge		14			
Q _{godr}	Gate Charge Overdrive		9.9			
Q _{sw}	Switch Charge (Q _{gs2} + Q _{gd})		17.4	_		
Q _{oss}	Output Charge		23		nC	$V_{DS} = 16V, V_{GS} = 0V$
t _{d(on)}	Turn-On Delay Time		12			$V_{DD} = 30V, V_{GS} = 10V$ ⑦
t _r	Rise Time		23			I _D = 41A
t _{d(off)}	Turn-Off Delay Time		19		ns	$R_G = 6.8\Omega$
t _f	Fall Time		14			
C _{iss}	Input Capacitance		2170			$V_{GS} = 0V$
C _{oss}	Output Capacitance		633		1	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		162		рF	f = 1.0MHz
C _{oss}	Output Capacitance		2661		1	$V_{GS} = 0V, V_{DS} = 1.0V, f=1.0MHz$
Coss	Output Capacitance		465		1	V _{GS} = 0V, V _{DS} = 48V, f=1.0MHz
C _{oss} eff.	Effective Output Capacitance		726		1	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 48V$

Diode Characteristics @ T_J = 25°C (unless otherwise stated)

	Parameter	Min.	Typ.	Max.	Units	Conditions	
Is	Continuous Source Current			68		MOSFET symbol	
	(Body Diode)			00	Α	showing the	
I _{SM}	Pulsed Source Current			272		integral reverse	
	(Body Diode) ^⑤		. 2/2			p-n junction diode.	
V _{SD}	Diode Forward Voltage			1.3	V	$I_S = 41A, V_{GS} = 0V$ ⑦	
t _{rr}	Reverse Recovery Time		36	54	ns	$I_F = 41A, V_{DD} = 25V$	
Q _{rr}	Reverse Recovery Charge		46	69	nC	di/dt = 100A/µs ⑦	



③ Surface mounted on 1 in. square Cu (still air).



Mounted to a PCB with small clip heatsink (still air)



 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

Notes ① through ⑩ are on page 10

Qualification Information[†]

		Automotive (per AEC-Q101) ^{††}			
Qualification Level		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture Sensitivity Level		MEDIUM-CAN MSL1, 260°C			
	Machine Madel	Class M4 (+/- 400V)			
	Machine Model	AEC-Q101-002			
FOD	II B. I M. I.I	Class H2(+/- 4000V)			
ESD	Human Body Model	AEC-Q101-001			
	Charged Device	N/A			
	Model	AEC-Q101-005			
RoHS Compliant		Yes			

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com

^{††} Exceptions to AEC-Q101 requirements are noted in the qualification report.

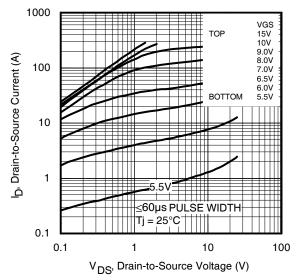
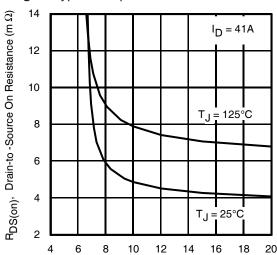


Fig 1. Typical Output Characteristics



V_{GS,} Gate -to -Source Voltage (V) **Fig 3.** Typical On-Resistance vs. Gate Voltage

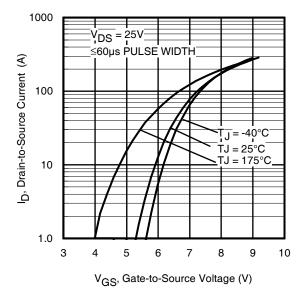


Fig 5. Typical Transfer Characteristics 4

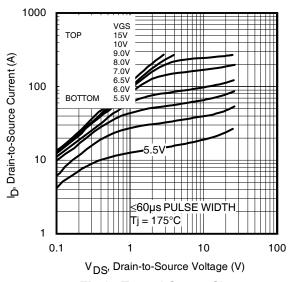


Fig 2. Typical Output Characteristics

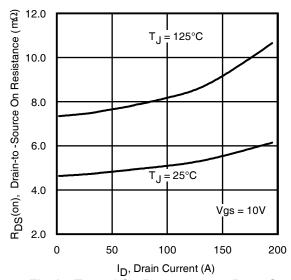


Fig 4. Typical On-Resistance vs. Drain Current

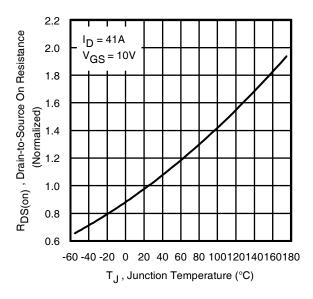
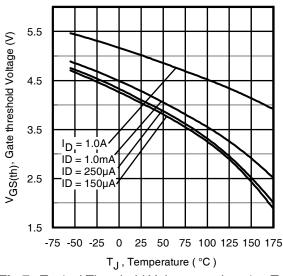


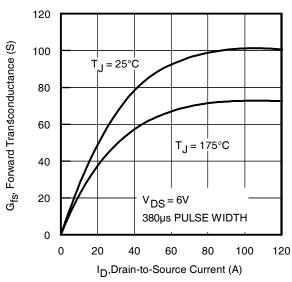
Fig 6. Normalized On-Resistance vs. Temperature www.irf.com



1000 I_{SD}, Reverse Drain Current (A) $T_J = -40^{\circ}C$ 100 TJ = 25°C= TJ = 175°C 10 V_{GS}'= 0V 1.0 0.2 0.8 1.2 0.4 0.6 1.0 V_{SD}, Source-to-Drain Voltage (V)

Fig 7. Typical Threshold Voltage vs. Junction Temperature

Fig 8. Typical Source-Drain Diode Forward Voltage



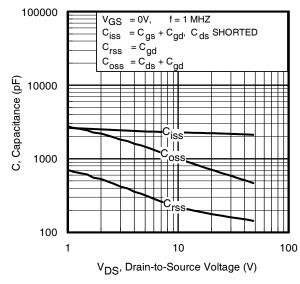
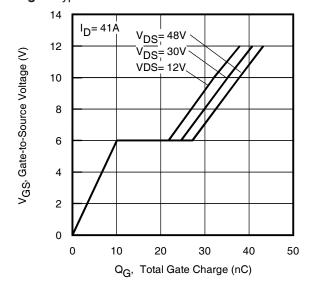


Fig 9. Typical Forward Transconductance Vs. Drain Current

Fig 10. Typical Capacitance vs.Drain-to-Source Voltage



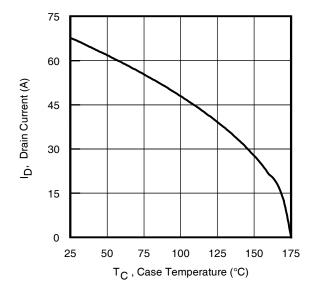


Fig.11 Typical Gate Charge vs.Gate-to-Source Voltage www.irf.com

Fig 12. Maximum Drain Current vs. Case Temperature 5

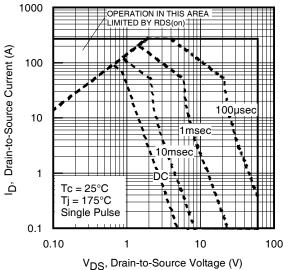


Fig 13. Maximum Safe Operating Area

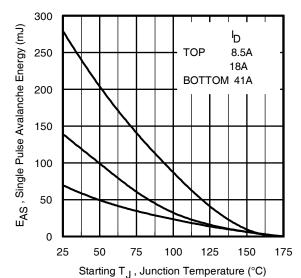


Fig 14. Maximum Avalanche Energy vs. Temperature

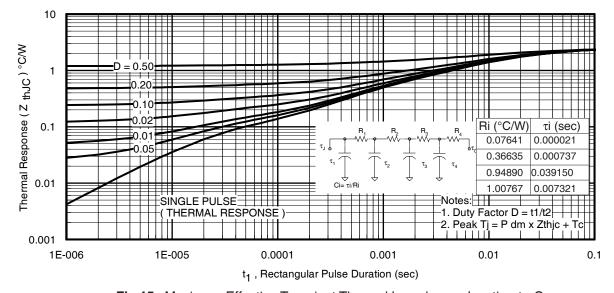


Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

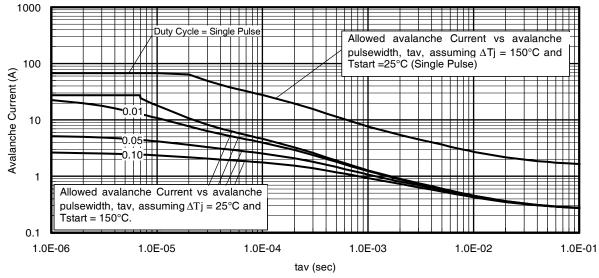


Fig 16. Typical Avalanche Current Vs. Pulsewidth

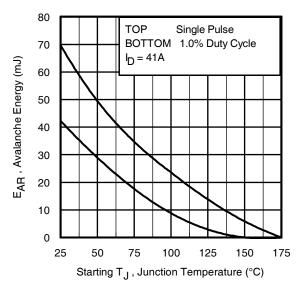


Fig 17. Maximum Avalanche Energy Vs. Temperature

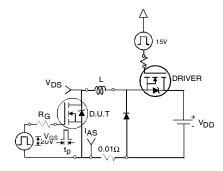


Fig 18a. Unclamped Inductive Test Circuit

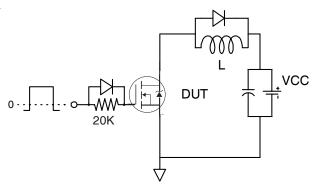


Fig 19a. Gate Charge Test Circuit

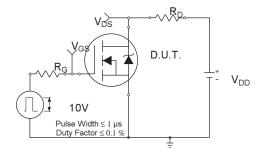


Fig 20a. Switching Time Test Circuit

Notes on Repetitive Avalanche Curves, Figures 16, 17: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. P_{D (ave)} = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 16, 17).

t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see figure 15)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ (} 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} = \triangle \text{T/ Z}_{thJC} \\ I_{av} &= 2\triangle \text{T/ [1.3} \cdot \text{BV} \cdot \text{Z}_{th}] \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

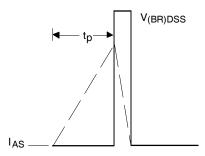


Fig 18b. Unclamped Inductive Waveforms

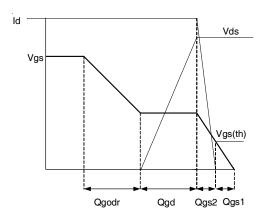


Fig 19b. Gate Charge Waveform

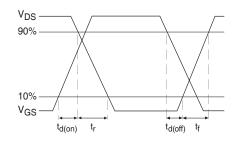
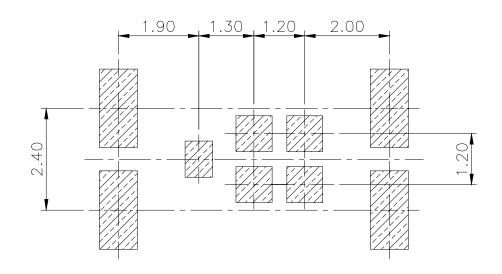
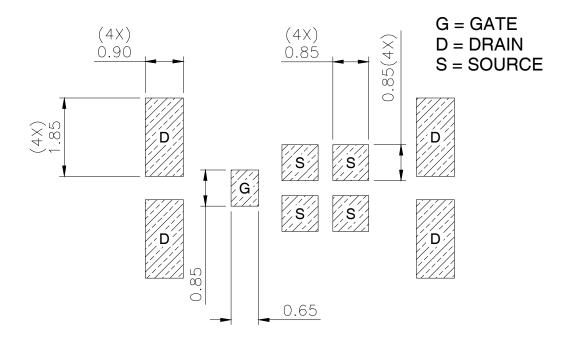


Fig 20b. Switching Time Waveforms

DirectFET® Board Footprint, M4 (Medium Size Can).

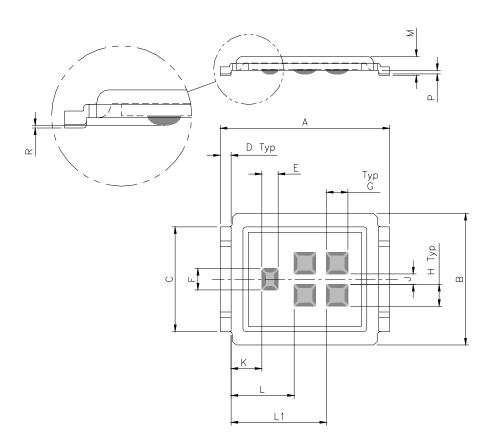
Please see AN-1035 for DirectFET® assembly details and stencil and substrate design recommendations





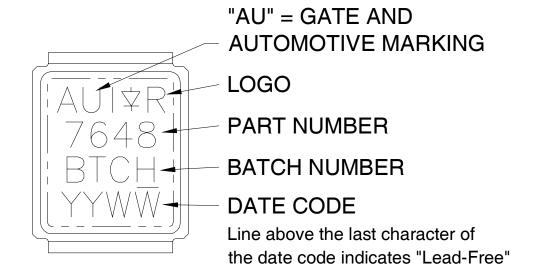
DirectFET® Outline Dimension, M4 Outline (Medium Size Can).

Please see AN-1035 for DirectFET® assembly details and stencil and substrate design recommendations



	DIMENSIONS							
	METRIC IMPERIAL			RIAL				
CODE	MIN	MAX	MIN	MAX				
Α	6.25	6.35	0.246	0.250				
В	4.80	5.05	0.189	0.201				
С	3.85	3.95	0.152	0.156				
D	0.35	0.45	0.014	0.018				
Е	0.58	0.62	0.023	0.024				
F	0.78	0.82	0.031	0.032				
G	0.78	0.82	0.031	0.032				
Н	0.78	0.82	0.031	0.032				
J	0.38	0.42	0.015	0.017				
K	1.10	1.20	0.043	0.047				
L	2.30	2.40	0.090	0.094				
L1	3.50	3.60	0.138	0.142				
М	0.68	0.74	0.027	0.029				
Р	0.09	0.17	0.003	0.007				
R	0.02	0.08	0.001	0.003				

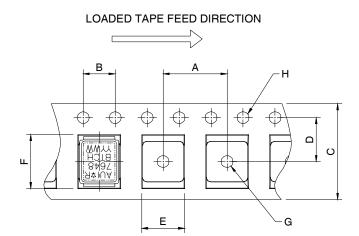
DirectFET® Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/ www.irf.com

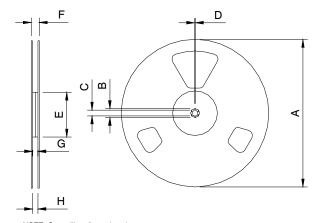


DirectFET® Tape & Reel Dimension (Showing component orientation).



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS							
	MET	RIC	IMPE	RIAL			
CODE	MIN	MAX	MIN	MAX			
Α	7.90	8.10	0.311	0.319			
В	3.90	4.10	0.154	0.161			
С	11.90	12.30	0.469	0.484			
D	5.45	5.55	0.215	0.219			
E	5.10	5.30	0.201	0.209			
F	6.50	6.70	0.256	0.264			
G	1.50	N.C	0.059	N.C			
Н	1.50	1.60	0.059	0.063			



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts. (ordered as AUIRF7648M2TR). For 1000 parts on 7" reel, order AUIRF7648M2TR1

	REEL DIMENSIONS								
S ⁻	STANDARD OPTION (QTY 4800)					TR1 OPTION (QTY 1000)			
	ME	TRIC	IMP	ERIAL	ME	TRIC	IMP	ERIAL	
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
Α	330.0	N.C	12.992	N.C	177.77	N.C	6.9	N.C	
В	20.2	N.C	0.795	N.C	19.06	N.C	0.75	N.C	
С	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50	
D	1.5	N.C	0.059	N.C	1.5	N.C	0.059	N.C	
E	100.0	N.C	3.937	N.C	58.72	N.C	2.31	N.C	
F	N.C	18.4	N.C	0.724	N.C	13.50	N.C	0.53	
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C	
Н	11.9	15.4	0.469	0.606	11.9	12 01	0.47	NC	

Notes:

- ① Click on this section to link to the appropriate technical paper.
- $\ensuremath{\mathbb{Q}}$ Click on this section to link to the <code>DirectFET</code> Website.
- 3 Surface mounted on 1 in. square Cu board, steady state.
- $\ensuremath{\mathfrak{G}}$ T_C measured with thermocouple mounted to top (Drain) of part.
- ⑤ Repetitive rating; pulse width limited by max. junction temperature.
- © Starting $T_J = 25$ °C, L = 0.084mH, $R_G = 50\Omega$, $I_{AS} = 41$ A,Vgs = 20V.
- Pulse width $\le 400 \mu s$; duty cycle $\le 2 \%$.
- ® Used double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- $^{\circ}$ R_{θ} is measured at T_J of approximately 90°C.

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